Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/789,208	CHEN ET AL.
Examiner	Art Unit
Sam Chuan C Vaa	1722

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (427/74,76,256,258,261,269,355,356, 358, 384,389.7-389.9; 118/303,314,316)	8/31/2005	SCY